

Notice of References Cited	Application/Control No. 10/524,804	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
	Examiner Debra Wolfe	Art Unit 3725	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,520,075 B1	02-2003	Shinoda et al.	100/214
	B	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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X	O	JP 2001-96397A	04-2001	Japan	AMINO et al.	
	P					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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